Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10533632	TAKASE ET AL.
Examiner	Art Unit

HUYEN D LE

2614

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Class	Subclass	Date	Examiner	
381	152, 184, 398, 403, 423, 424, 430, 431	12/05/08	HL	
181	163, 164, 165, 171	12/05/08	HL	
379	431, 433.02, 432	12/05/08	HL	

SEARCH NOTES		
Search Notes	Date	Examiner

	INTERFERENCE SEAR	СН	
Class	Subclass	Date	Examiner

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